

ZXMN3G32DN8 30V SO8 dual N-channel enhancement mode MOSFET

Summary

V _{(BR)DSS}	R _{DS(on)} (Ω)	I _D (A)
30	0.028 @ V _{GS} = 10V	7.1
	0.045 @ V _{GS} = 4.5V	5.6



Description

This new generation Trench MOSFET from Zetex features low on-resistance and fast switching speed.

Features

- · Low on-resistance
- 4.5V gate drive capability
- Fast switching bullet

Applications

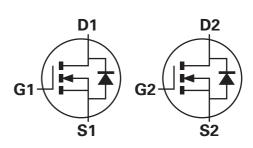
- DC-DC Converters
- Power management functions
- Motor Control
- Backlighting

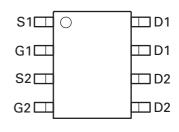
Ordering information

DEVICE	Reel size	Tape width	Quantity	
	(inches)	(mm)	per reel	
ZXMN3G32DN8TA	7	12	500	

Device marking

ZXMN 3G32D





Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Drain source voltage	V _{DSS}	30	V
Gate source voltage	V _{GS}	±20	V
Continous Drain Current @ $V_{GS}=10$; $T_A=25^{\circ}C^{(b)}$ @ $V_{GS}=10$; $T_A=70^{\circ}C^{(b)}$ @ $V_{GS}=10$; $T_A=25^{\circ}C^{(a)}$	ID	7.1 5.7 5.5	A A A
Pulsed drain current ^(c)	I _{DM}	33.6	А
Continuous source current (body diode) ^(b)	ا _S	3.1	А
Pulsed source current (body diode) ^(c)	I _{SM}	33.6	А
Power dissipation at $T_A = 25^{\circ}C^{(a)(d)}$	PD	1.25	W
Linear derating factor		10	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(a)(e)}$	PD	1.8	W
Linear derating factor		14	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(b)(d)}$	PD	2.1	W
Linear derating factor		17	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient ^{(a)(d)}	R _{OJA}	100	°C/W
Junction to ambient ^{(a)(e)}	R _{OJA}	70	°C/W
Junction to ambient ^{(b)(d)}	R _{OJA}	60	°C/W
Junction to lead ^(f)	R _{OJL}	51	°C/W

NOTES:

(a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

(b) For a device surface mounted on FR4 PCB measured at t \leq 10 sec.

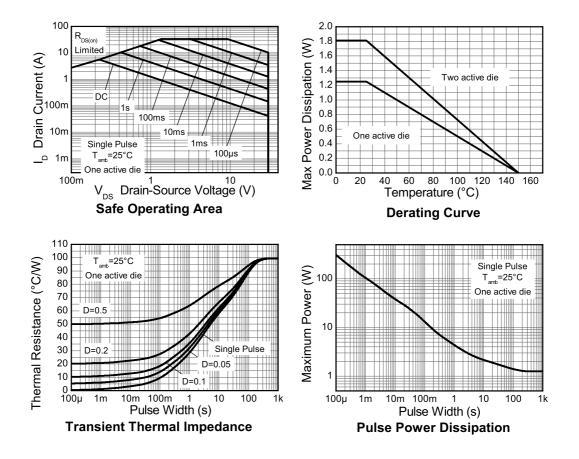
(c) Repetitive rating - 25mm x 25mm FR4 PCB, D=0.02, pulse width 300μs - pulse width limited by maximum junction temperature.

(d) For a dual device with one active die.

(e) For a device with two active die running at equal power.

(f) Thermal resistance from junction to solder-point (at end of drain lead).

Thermal characteristics



Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Static	1		I	•		
Drain-Source Breakdown Voltage	V _{(BR)DSS}	30			V	I _D = 250μA, V _{GS} =0V
Zero Gate Voltage Drain Current	I _{DSS}			0.5	μA	V _{DS} = 30V, V _{GS} =0V
Gate-Body Leakage	I _{GSS}			100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Gate-Source Threshold Voltage	V _{GS(th)}	1.0		3.0	V	$I_D=250\mu A, V_{DS}=V_{GS}$
Static Drain-Source On-State Resistance ^(*)	R _{DS(on)}			0.028 0.045	Ω Ω	V _{GS} = 10V, I _D = 6.0A V _{GS} = 4.5V, I _D = 4.9A
Forward Transconductance ^{(*)(†)}	9 _{fs}		12		S	V _{DS} = 15V, I _D = 6.0A
Dynamic ^(†)	· · · · ·		1	•	1	
Input Capacitance	C _{iss}		472		pF	
Output Capacitance	C _{oss}		178		pF	V _{DS} = 15V, V _{GS} =0V f=1MHz
Reverse Transfer Capacitance	C _{rss}		65		pF	- 1 - 1101112
Switching ^{(‡)(†)}						
Turn-On-Delay Time	t _{d(on)}		2.5		ns	
Rise Time	t _r		3.1		ns	V _{DD} = 15V, I _D = 1A R _G ≅ 6.0Ω, V _{GS} =10V
Turn-Off Delay Time	t _{d(off)}		14		ns	$M_{\rm G} = 0.052, V_{\rm GS} = 10V$
Fall Time	t _f		9.7		ns	
Total Gate Charge	Qg		10.5		nC	V _{DS} = 15V, V _{GS} = 10V
Gate-Source Charge	Q _{gs}		1.86		nC	I _D = 6A
Gate Drain Charge	Q _{gd}		2.3		nC	1
Source-drain diode	1		1	1		
Diode Forward Voltage ^(*)	V _{SD}		0.68	1.2	V	T _j =25°C, I _S = 1.7A, V _{GS} =0V

Electrical characteristics (at $T_{amb} = 25^{\circ}C$ unless otherwise stated)

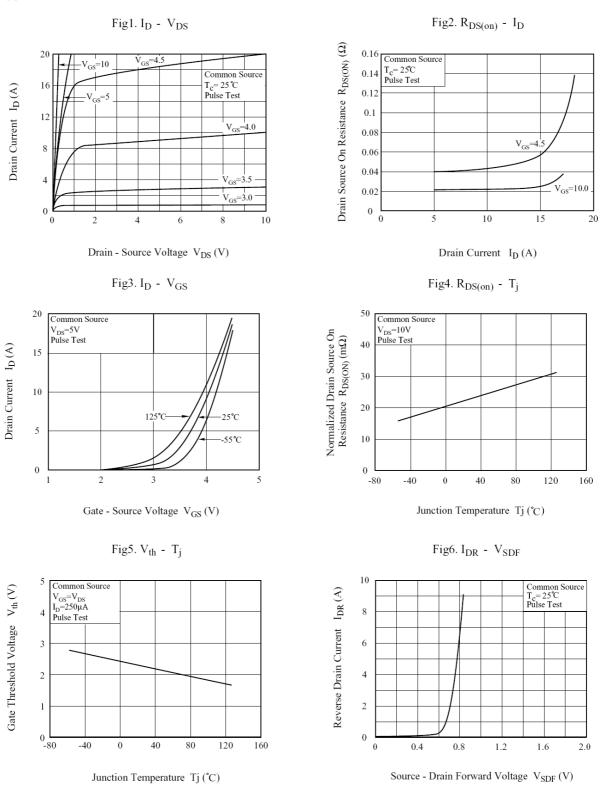
NOTES:

(*) Measured under pulsed conditions. Pulse width \leq 300 $\mu s;$ duty cycle $\leq\!\!2\%.$

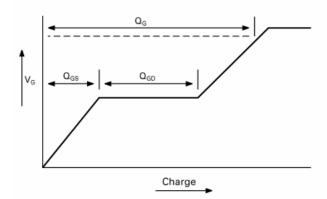
(†) For design aid only, not subject to production testing

(‡) Switching characteristics are independent of operating junction temperature.

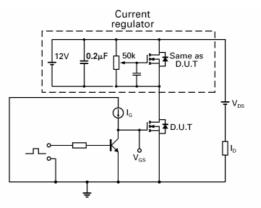
Typical characteristics



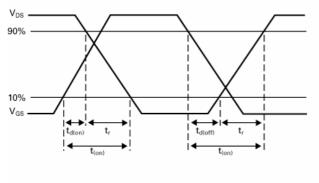
Test circuits



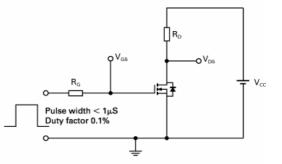
Basic gate charge waveform



Gate charge test circuit

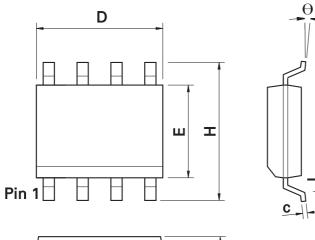


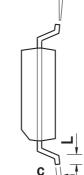
Switching time waveforms

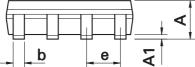


Switching time test circuit

Package outline - SO8







Seating Plane

DIM	Inc	hes	Millin	neters	DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.053	0.069	1.35	1.75	е	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	С	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	θ	0°	8°	0°	8°
E	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	-

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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